


<b>Search Notes</b>  	<b>Application/Control No.</b>  10534153	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  Dabney, Phylesha L	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
379	419, 428.01		
455	575.1-575.9		
343	702		
361	816, 814		

SEARCH NOTES		
Search Notes	Date	Examiner
379/ text search.	6/22/07	pld
379/419,429	6/22/07	pld
343/antennas	6/22/07	pld

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner